

Search Notes

Application/Control No.

10/755,446

Examiner

James D. Stein

Applicant(s)/Patent under
Reexamination

MUKAI, KOHKI

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
398	52,53,98, 102	3/29/2005	JDS jw
385	16, 45, 4	3/29/2005	JDS jw

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
files	removed	3/29/2005	JDS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history	3/29/2005	JDS jw
IEEE and INSPEC databases: switch, branch, first input, second input, drop device, DMUX, delay, control carrier with signal	3/29/2005	JDS jw